Metal-dielectric interfaces in gigascale electronics: thermal and electrical stability

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Abstrak

In this book, the authors present the basic science underlying the thermal and electrical stability of metaldielectric interfaces and its relationship to the operation of advanced interconnect systems in gigascale electronics. Interface phenomena, including chemical reactions between metals and dielectrics, metallicatom diffusion, and ion drift, are discussed based on fundamental physical and chemical principles. Schematic diagrams are provided throughout the book to illustrate interface phenomena and the principles that govern them.